.Manual on.

ELECTRON METALLOGRAPHY TECHNIQUES

STP 547



AMERICAN SOCIETY FOR TESTING AND MATERIALS

MANUAL ON ELECTRON METALLOGRAPHY TECHNIQUES

Sponsored by
Subcommittee E04.11 on
Electron Microscopy and Diffraction of
Committee E-4 on Metallography
AMERICAN SOCIETY FOR TESTING
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Foreword

The Manual on Electron Metallography Techniques was sponsored and compiled by Subcommittee E04.11 on Electron Microscopy and Diffraction of Committee E-4 on Metallography, American Society for Testing and Materials. Subcommittee E04.11 officers are G. N. Maniar, chairman, and Albert Szirmae, secretary.

Related ASTM Publications

Applications of Modern Metallographic Techniques, STP 480 (1970), \$17.00 (04-480000-28)

Application of Electron Microfractography to Materials Research, STP 493 (1971), \$8.25 (04-493000-30)

Stereology and Quantitative Metallography, STP 504 (1972), \$9.75 (04-504000-28)

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